

Notice of References Cited	Application/Control No. 10/806,255	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner (Nancy) Thanh-Nhan P. Nguyen	Art Unit 2871	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2004/0263702	12-2004	Kim, Dong-Gyu	349/038
	C	US-6,195,140	02-2001	Kubo et al.	349/44
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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